

## Special Issue

# Trends and Prospects in Applied Electromagnetics

### Message from the Guest Editors

We are inviting submissions to the Special Issue on the “Trends and Prospects in Applied Electromagnetics”. Electromagnetics is widely applied in various fields, such as communication, navigation, radar, measurement and instrument, as well as in electric vehicles. This Special Issue is focused on, but not limited to: advanced electromagnetic materials, such as metamaterials; electromagnetic theories, including transmission, propagation, radiation and scattering theory; nondestructive testing and evaluation, including eddy current technique, magnetic flux linkage technique, Buckhausen noise method, alternative current field measurement, and so on; computational electromagnetics; electromagnetic sensing and imaging, including microwave and millimeter-wave imaging, radar imaging, RF and wireless communication and sensing, as well as THz imaging; electromagnetic compatibility and interference, including EMC and EMI modeling; EMC standards, methods of EMC measurements and signal and power integrity; as well as electromagnetic application in IOTs.

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### Guest Editors

Dr. Yating Yu

School of Mechanical and Electrical Engineering, University of Electronic Science and Technology, Chengdu 611731, China

Dr. Baolin Nie

School of Mechanical and Electrical Engineering, University of Electronic Science and Technology, Chengdu 611731, China

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### Deadline for manuscript submissions

closed (20 May 2025)



## Applied Sciences

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*Applied Sciences*  
Editorial Office  
MDPI, Grosspeteranlage 5  
4052 Basel, Switzerland  
Tel: +41 61 683 77 34  
[appls@mdpi.com](mailto:appls@mdpi.com)

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### Message from the Editor-in-Chief

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal *Applied Sciences* has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

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### Editor-in-Chief

Prof. Dr. Giulio Nicola Cerullo  
Dipartimento di Fisica, Politecnico di Milano, Piazza L. da Vinci 32,  
20133 Milano, Italy

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